

# SN54LV574A, SN74LV574A OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

SCLS412C – APRIL 1998 – REVISED MAY 2000

- **EPIC™ (Enhanced-Performance Implanted CMOS) Process**
- **Typical  $V_{OLP}$  (Output Ground Bounce)**  
 $<0.8\text{ V}$  at  $V_{CC} = 3.3\text{ V}$ ,  $T_A = 25^\circ\text{C}$
- **Typical  $V_{OHV}$  (Output  $V_{OH}$  Undershoot)**  
 $>2.3\text{ V}$  at  $V_{CC} = 3.3\text{ V}$ ,  $T_A = 25^\circ\text{C}$
- **2-V to 5.5-V  $V_{CC}$  Operation**
- **Support Mixed-Mode Voltage Operation on All Ports**
- **Latch-Up Performance Exceeds 250 mA Per JESD 17**
- **ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ( $C = 200\text{ pF}$ ,  $R = 0$ )**
- **Package Options Include Plastic Small-Outline (DW, NS), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), and Thin Shrink Small-Outline (PW) Packages, Ceramic Flat (W) Packages, Chip Carriers (FK), and DIPs (J)**

## description

The 'LV574A devices are octal edge-triggered D-type flip-flops designed for 2-V to 5.5-V  $V_{CC}$  operation.

These devices feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. The devices are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

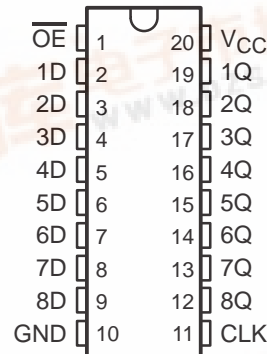
A buffered output-enable ( $\overline{OE}$ ) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

$\overline{OE}$  does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

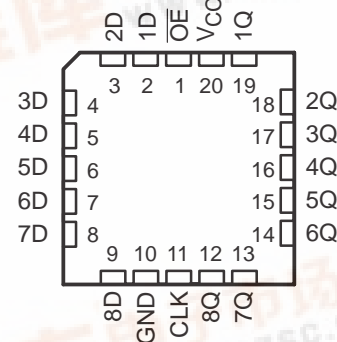
To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54LV574A is characterized for operation over the full military temperature range of  $-55^\circ\text{C}$  to  $125^\circ\text{C}$ . The SN74LV574A is characterized for operation from  $-40^\circ\text{C}$  to  $85^\circ\text{C}$ .

SN54LV574A ... J OR W PACKAGE  
SN74LV574A ... DB, DGV, DW, NS, OR PW PACKAGE  
(TOP VIEW)



SN54LV574A ... FK PACKAGE  
(TOP VIEW)



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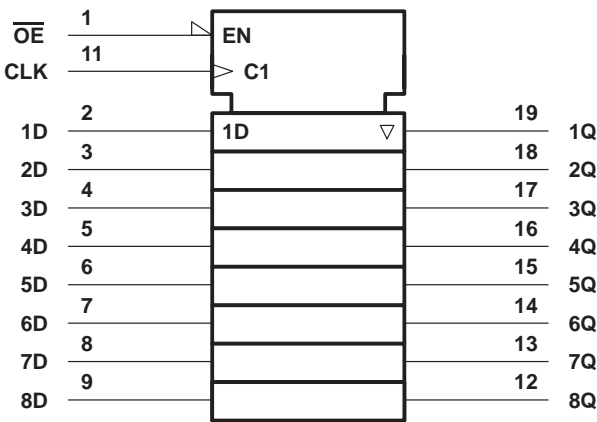
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SCLS412C – APRIL 1998 – REVISED MAY 2000

FUNCTION TABLE  
(each flip-flop)

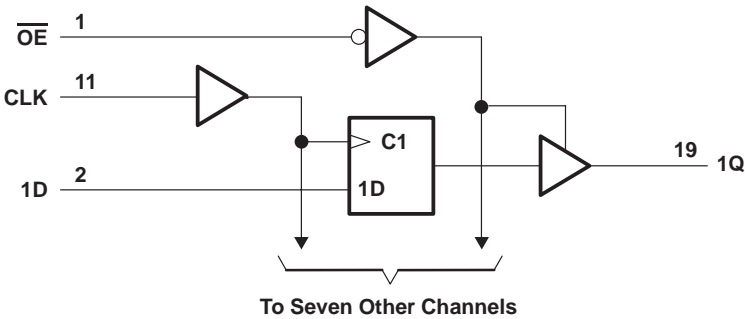
INPUTS			OUTPUT Q
$\overline{OE}$	CLK	D	
L	$\uparrow$	H	H
L	$\uparrow$	L	L
L	H or L	X	$Q_0$
H	X	X	Z

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



## SCLS412C – APRIL 1998 – REVISED MAY 2000

# SN54LV574A, SN74LV574A

## OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS

### WITH 3-STATE OUTPUTS

SCLS412C – APRIL 1998 – REVISED MAY 2000

#### recommended operating conditions (see Note 4)

			SN54LV574A		SN74LV574A		UNIT
			MIN	MAX	MIN	MAX	
V <sub>CC</sub>	Supply voltage		2	5.5	2	5.5	V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 2 V	1.5		1.5		V
		V <sub>CC</sub> = 2.3 V to 2.7 V	V <sub>CC</sub> × 0.7		V <sub>CC</sub> × 0.7		
		V <sub>CC</sub> = 3 V to 3.6 V	V <sub>CC</sub> × 0.7		V <sub>CC</sub> × 0.7		
		V <sub>CC</sub> = 4.5 V to 5.5 V	V <sub>CC</sub> × 0.7		V <sub>CC</sub> × 0.7		
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 2 V	0.5		0.5		V
		V <sub>CC</sub> = 2.3 V to 2.7 V	V <sub>CC</sub> × 0.3		V <sub>CC</sub> × 0.3		
		V <sub>CC</sub> = 3 V to 3.6 V	V <sub>CC</sub> × 0.3		V <sub>CC</sub> × 0.3		
		V <sub>CC</sub> = 4.5 V to 5.5 V	V <sub>CC</sub> × 0.3		V <sub>CC</sub> × 0.3		
V <sub>I</sub>	Input voltage		0	5.5	0	5.5	V
V <sub>O</sub>	Output voltage	High or low state	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
		3-state	0	5.5	0	5.5	
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 2 V	–50		–50		μA
		V <sub>CC</sub> = 2.3 V to 2.7 V	–2		–2		mA
		V <sub>CC</sub> = 3 V to 3.6 V	–8		–8		
		V <sub>CC</sub> = 4.5 V to 5.5 V	–16		–16		
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2 V	50		50		μA
		V <sub>CC</sub> = 2.3 V to 2.7 V	2		2		mA
		V <sub>CC</sub> = 3 V to 3.6 V	8		8		
		V <sub>CC</sub> = 4.5 V to 5.5 V	16		16		
Δt/Δv	Input transition rise or fall rate	V <sub>CC</sub> = 2.3 V to 2.7 V	0	200	0	200	ns/V
		V <sub>CC</sub> = 3 V to 3.6 V	0	100	0	100	
		V <sub>CC</sub> = 4.5 V to 5.5 V	0	20	0	20	
T <sub>A</sub>	Operating free-air temperature		–55	125	–40	85	°C

NOTE 4: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	SN54LV574A			SN74LV574A			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
V <sub>OH</sub>	I <sub>OH</sub> = –50 μA	2 V to 5.5 V	V <sub>CC</sub> –0.1			V <sub>CC</sub> –0.1			V
	I <sub>OH</sub> = –2 mA	2.3 V	2			2			
	I <sub>OH</sub> = –8 mA	3 V	2.48			2.48			
	I <sub>OH</sub> = –16 mA	4.5 V	3.8			3.8			
V <sub>OL</sub>	I <sub>OL</sub> = 50 μA	2 V to 5.5 V			0.1			0.1	V
	I <sub>OL</sub> = 2 mA	2.3 V			0.4			0.4	
	I <sub>OL</sub> = 8 mA	3 V			0.44			0.44	
	I <sub>OL</sub> = 16 mA	4.5 V			0.55			0.55	
I <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	0 V to 5.5 V			±1			±1	μA
I <sub>OZ</sub>	V <sub>O</sub> = V <sub>CC</sub> or GND	5.5 V			±5			±5	μA
I <sub>CC</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND, I <sub>O</sub> = 0	5.5 V			20			20	μA
I <sub>off</sub>	V <sub>I</sub> or V <sub>O</sub> = 0 to 5.5 V	0 V			5			5	μA
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		1.8			1.8		pF

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# SN54LV574A, SN74LV574A OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

SCLS412C – APRIL 1998 – REVISED MAY 2000

timing requirements over recommended operating free-air temperature range,  $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$  (unless otherwise noted) (see Figure 1)

PARAMETER			$T_A = 25^\circ\text{C}$		SN54LV574A		SN74LV574A		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
$t_W$	Pulse duration	CLK high or low	7		7		7		ns
$t_{su}$	Setup time	High or low before CLK $\uparrow$	5.5		5.5		5.5		ns
$t_h$	Hold time	Data after CLK $\uparrow$	2		2		2		ns

timing requirements over recommended operating free-air temperature range,  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$  (unless otherwise noted) (see Figure 1)

PARAMETER			$T_A = 25^\circ\text{C}$		SN54LV574A		SN74LV574A		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
$t_W$	Pulse duration	CLK high or low	5		5		5		ns
$t_{su}$	Setup time	High or low before CLK $\uparrow$	3.5		3.5		3.5		ns
$t_h$	Hold time	Data after CLK $\uparrow$	1.5		1.5		1.5		ns

timing requirements over recommended operating free-air temperature range,  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$  (unless otherwise noted) (see Figure 1)

PARAMETER			$T_A = 25^\circ\text{C}$		SN54LV574A		SN74LV574A		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
$t_W$	Pulse duration	CLK high or low	5		5		5		ns
$t_{su}$	Setup time	High or low before CLK $\uparrow$	3.5		3.5		3.5		ns
$t_h$	Hold time	Data after CLK $\uparrow$	1.5		1.5		1.5		ns

switching characteristics over recommended operating free-air temperature range,  $V_{CC} = 2.5\text{ V} \pm 0.2\text{ V}$  (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	$T_A = 25^\circ\text{C}$			SN54LV574A		SN74LV574A		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
$f_{max}$			$C_L = 15\text{ pF}$	60*	100*		50*		50		MHz
			$C_L = 50\text{ pF}$	50	85		40		40		
$t_{pd}$	CLK	Q	$C_L = 15\text{ pF}$	9.6*	16.6*		1*	20*	1	20	ns
$t_{en}$	$\overline{OE}$	Q		9.2*	16.1*		1*	19*	1	19	
$t_{dis}$	$\overline{OE}$	Q		6.5*	12.8*		1*	15*	1	15	
$t_{pd}$	CLK	Q	$C_L = 50\text{ pF}$	11.6	19.6		1	23	1	23	ns
$t_{en}$	$\overline{OE}$	Q		10.9	19		1	22	1	22	
$t_{dis}$	$\overline{OE}$	Q		8.4	17.5		1	20	1	20	
$t_{sk(o)}$					2					2	

\* On products compliant to MIL-PRF-38535, this parameter is not production tested.

# SN54LV574A, SN74LV574A

## OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS

### WITH 3-STATE OUTPUTS

SCLS412C – APRIL 1998 – REVISED MAY 2000

**switching characteristics over recommended operating free-air temperature range,  
V<sub>CC</sub> = 3.3 V ± 0.3 V (unless otherwise noted) (see Figure 1)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T <sub>A</sub> = 25°C			SN54LV574A		SN74LV574A		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			C <sub>L</sub> = 15 pF	80*	145*		65*		65		MHz
			C <sub>L</sub> = 50 pF	50	120		45		45		
t <sub>pd</sub>	CLK	Q	C <sub>L</sub> = 15 pF		6.8*	13.2*	1*	15.5*	1	15.5	ns
t <sub>en</sub>	$\overline{\text{OE}}$	Q			6.4*	12.8*	1*	15*	1	15	
t <sub>dis</sub>	$\overline{\text{OE}}$	Q			4.8*	13*	1*	15*	1	15	
t <sub>pd</sub>	CLK	Q	C <sub>L</sub> = 50 pF		8.1	16.7	1	19	1	19	ns
t <sub>en</sub>	$\overline{\text{OE}}$	Q			7.7	16.3	1	18.5	1	18.5	
t <sub>dis</sub>	$\overline{\text{OE}}$	Q			6.1	15	1	17	1	17	
t <sub>sk(o)</sub>					1.5					1.5	

\* On products compliant to MIL-PRF-38535, this parameter is not production tested.

**switching characteristics over recommended operating free-air temperature range,  
V<sub>CC</sub> = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T <sub>A</sub> = 25°C			SN54LV574A		SN74LV574A		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			C <sub>L</sub> = 15 pF	130*	205*		110*		110		MHz
			C <sub>L</sub> = 50 pF	85	175		75		75		
t <sub>pd</sub>	CLK	Q	C <sub>L</sub> = 15 pF		4.8*	8.6*	1*	10*	1	10	ns
t <sub>en</sub>	$\overline{\text{OE}}$	Q			4.6*	9*	1*	10.5*	1	10.5	
t <sub>dis</sub>	$\overline{\text{OE}}$	Q			3.5*	9*	1*	10.5*	1	10.5	
t <sub>pd</sub>	CLK	Q	C <sub>L</sub> = 50 pF		5.7	10.6	1	12	1	12	ns
t <sub>en</sub>	$\overline{\text{OE}}$	Q			5.5	11	1	12.5	1	12.5	
t <sub>dis</sub>	$\overline{\text{OE}}$	Q			4.1	10.1	1	11.5	1	11.5	
t <sub>sk(o)</sub>					1					1	

\* On products compliant to MIL-PRF-38535, this parameter is not production tested.

**noise characteristics, V<sub>CC</sub> = 3.3 V, C<sub>L</sub> = 50 pF, T<sub>A</sub> = 25°C (see Note 5)**

PARAMETER				SN74LV574A			UNIT
				MIN	TYP	MAX	
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>				0.7	0.8	V
V <sub>OL(V)</sub>	Quiet output, minimum dynamic V <sub>OL</sub>				−0.6	−0.8	V
V <sub>OH(V)</sub>	Quiet output, minimum dynamic V <sub>OH</sub>				2.8		V
V <sub>IH(D)</sub>	High-level dynamic input voltage				2.31		V
V <sub>IL(D)</sub>	Low-level dynamic input voltage					0.99	V

NOTE 5: Characteristics are for surface-mount packages only.

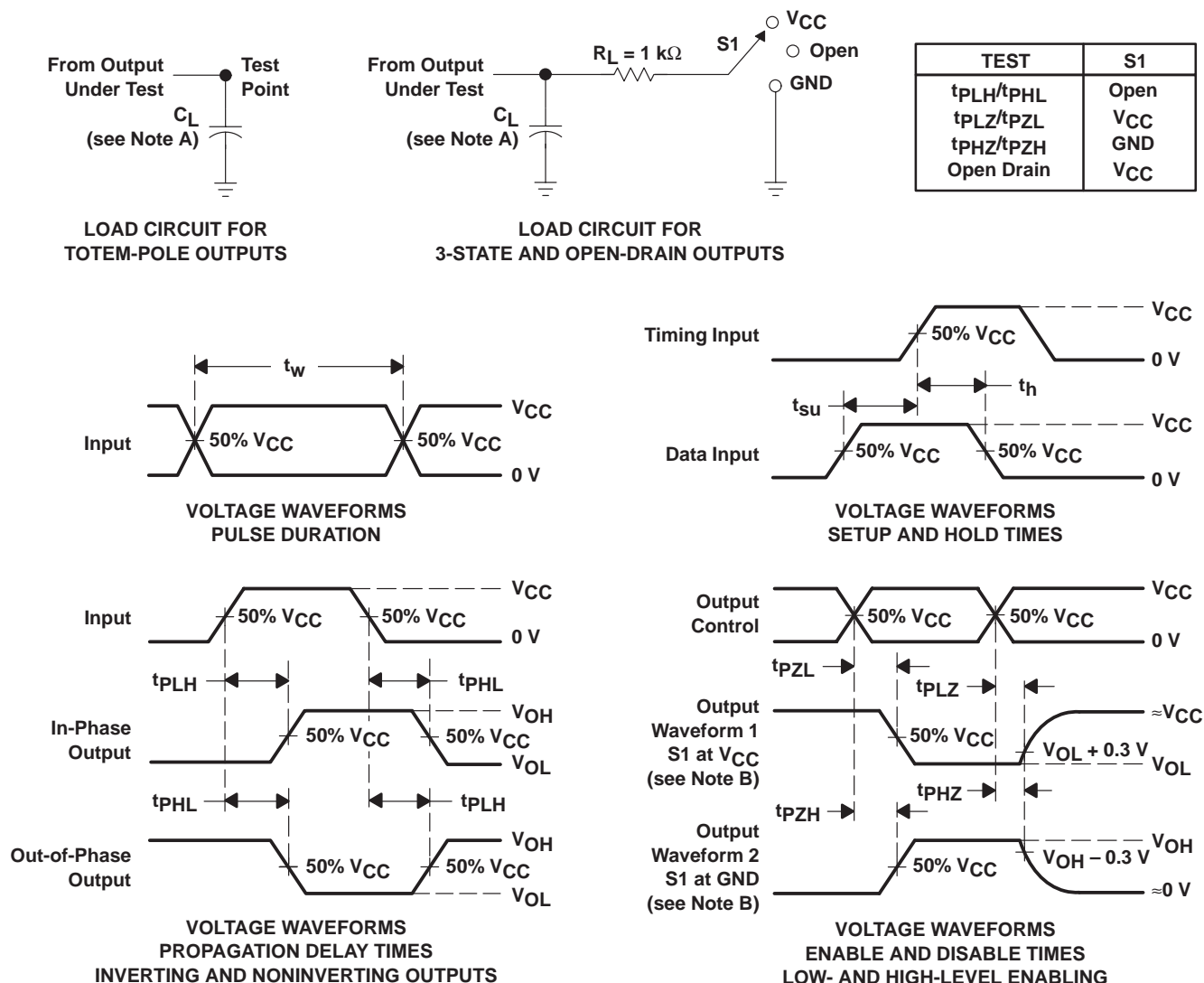
**operating characteristics, T<sub>A</sub> = 25°C**

PARAMETER		TEST CONDITIONS		V <sub>CC</sub>	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	Outputs enabled	C <sub>L</sub> = 50 pF, f = 10 MHz	3.3 V	20.4	pF
				5 V	23.8	

# SN54LV574A, SN74LV574A OCTAL EDGE-TRIGGERED D-TYPE FLIP-FLOPS WITH 3-STATE OUTPUTS

SCLS412C – APRIL 1998 – REVISED MAY 2000

## PARAMETER MEASUREMENT INFORMATION



- NOTES:
- A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 1\text{ MHz}$ ,  $Z_O = 50\ \Omega$ ,  $t_r \leq 3\text{ ns}$ ,  $t_f \leq 3\text{ ns}$ .
  - D. The outputs are measured one at a time with one input transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G.  $t_{PHL}$  and  $t_{PLH}$  are the same as  $t_{pd}$ .

Figure 1. Load Circuit and Voltage Waveforms

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